MOSFET - Power, N-Channel PowerTrench® Power Clip 25 V Asymmetric Dual

NTTFD1D8N02P1E

Features

- Small Footprint (3.3mm x 3.3mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- These Devices are Pb-Free and are RoHS Compliant

Typical Applications

- DC-DC Converters
- System Voltage Rails

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parar	Symbol	Q1	Q2	Unit		
Drain-to-Source Volt	V _{DSS}	25	25	V		
Gate-to-Source Volta	age		V_{GS}	+16 -12	+16 -12	>
Continuous Drain Current R _{θJC}		T _C = 25°C	I _D	61	126	Α
(Note 3)	Steady	T _C = 85°C		44	91	
Power Dissipation $R_{\theta JC}$ (Note 3)	State	T _A = 25°C	P _D	25	36	W
Continuous Drain Current R _{θJA}		T _A = 25°C	I _D	15	30	Α
(Notes 1, 3)	Steady	T _A = 85°C		11	21	
Power Dissipation R _{θJA} (Notes 1, 3)	State	T _A = 25°C	P _D	1.6	2.0	W
Continuous Drain Current R _{B.IA}		T _A = 25°C	I _D	11	21	Α
(Notes 2, 3)	Steady	T _A = 85°C		8	15	
Power Dissipation R _{θJA} (Notes 2, 3)	State	T _A = 25°C	P _D	0.8	0.9	W
Pulsed Drain Current	$T_A = 25^{\circ}$	C, t _p = 10 μs	I _{DM}	483	861	Α
Single Pulse Drain-to-Source Avalanche Energy Q1: $I_L = 15.8 A_{pk}$, $L = 0.3 mH$ (Note 4) Q2: $I_L = 31.63 A_{pk}$, $L = 0.3 mH$ (Note 4)			E _{AS}	37.3	150. 1	mJ
Operating Junction and	T _J , T _{stg}	-55 to	+ 150	°C		
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	26	60	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Surface-mounted on FR4 board using a 1 in² pad size, 2 oz. Cu pad.
- 2. Surface-mounted on FR4 board using minimum pad size, 2 oz. Cu pad.
- 3. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted. Actual continuous current will be limited by thermal & electro–mechanical application board design. $R_{\theta,JC}$ is determined by the user's board design.
- Q1 100% UIS tested at L = 0.1 mH, IAS = 24.2 A.
 Q2 100% UIS tested at L = 0.1 mH, IAS = 48.1 A.
- 5. This device does not have ESD protection diode.



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FET	V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
Q1	25 V	4.2 m Ω @ 10 V	61 A
الع	25 V	5.3 mΩ @ 4.5 V	OIA
Q2	25 V	1.4 mΩ @ 10 V	126 A
ا لوک	25 V	1.8 mΩ @ 4.5 V	120 A

ELECTRICAL CONNECTION

HSG 1	PAD9 V+(HSD)	[8] v+	HSG	1 01 1 8 V+
sw 2	[17(11027)	[7] LSG	sw	2 7 LSG
sw 3	PAD10	GND	sw	3 sw 6 GND
sw 4	GND(LSS)	[5] GND	sw	4 5 GND
	<u> </u>			₩

MARKING DIAGRAM



PQFN12 3.3x3.3 CASE 483AZ



2EMN = Specific Device Code A = Assembly Location

Y = Year WW = Work Week ZZ = Assembly Lot Code

ORDERING INFORMATION

Device	Package	Shipping [†]
NTTFD1D8N02P1E	PQFN8 (Pb-Free)	3000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Q1 Max	Q2 Max	Unit
Junction-to-Case - Steady State (Notes 1, 3)	$R_{ heta JC}$	5.0	3.5	°C/W
Junction-to-Ambient - Steady State (Notes 1, 3)	$R_{ heta JA}$	77	63	
Junction-to-Ambient - Steady State (Notes 2, 3)	$R_{\theta JA}$	158	132	

Parameter	Symbol	Test Conditio	n	FET	Min	Тур	Max	Unit	
OFF CHARACTERISTICS	<u> </u>					I	I		
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		Q1	25			V	
	$V_{GS} = 0 \text{ V, } I_{D} = 1 \text{ mA}$		mA	Q2	25				
Drain-to-Source Breakdown	V _{(BR)DSS} / T _J	I _D = 250 μA, ref to 25°C		Q1		16			
Voltage Temperature Coefficient	ا ا	I _D = 1 mA, ref to 2	25°C	Q2		16		mV/°C	
Zero Gate Voltage Drain	I _{DSS}	I_{DSS} $V_{GS} = 0 V$, $V_{DS} = 20 V$	T _J = 25°C	Q1			10	_	
Current				Q2			10	μΑ	
Gate-to-Source Leakage	I _{GSS}	V _{DS} = 0 V, V _{GS} = +16	V / –12 V	Q1			±100		
Current		$V_{DS} = 0 \text{ V}, V_{GS} = +16$	V / –12 V	Q2			±100	nA	
ON CHARACTERISTICS (Note 6	6)								
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D = 1$	90 μΑ	Q1	1.2		2.0	.,	
		$V_{GS} = V_{DS}$, $I_D = 3$	10 μΑ	Q2	1.2		2.0	2.0 V	
Negative Threshold	V _{GS(TH)} /T _J	$V_{GS(TH)}/T_J$ $I_D = 190 \mu A$, ref to 25°		Q1		-4.4		mV/°C	
Temperature Coefficient		I _D = 310 μA, ref to 25°C		Q2		-4.7			
Drain-to-Source On	R _{DS(on)}	V _{GS} = 10 V, I _D = 15 A		Q1		3.3	4.2	- mΩ	
Resistance		V _{GS} = 4.5 V, I _D = 13 A				4.2	5.3		
		V _{GS} = 10 V, I _D = 29 A		Q2		1.04	1.4		
		$V_{GS} = 4.5 \text{ V}, I_D = 26 \text{ A}$				1.34	1.8		
Forward Transconductance	9FS	$V_{DS} = 5 \text{ V}, I_{D} = 15 \text{ A}$ $V_{DS} = 5 \text{ V}, I_{D} = 29 \text{ A}$		Q1		105		S	
				Q2		207			
Gate-Resistance	R_{G}	T _A = 25°C		Q1		0.54		Ω	
				Q2		0.45			
CHARGES, CAPACITANCES &	GATE RESISTA	NCE							
Input Capacitance	C _{ISS}			Q1		873			
				Q2		2700		pF	
Output Capacitance	C _{OSS}	V 0VV 40V	£ 4 MII-	Q1		243		pF	
		$V_{GS} = 0 \text{ V}, V_{DS} = 13 \text{ V},$, τ = 1 IVIHZ	Q2		748			
Reverse Transfer Capacitance	C _{RSS}			Q1		19		pF	
				Q2		48			

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

6. Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.

7. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition	FET	Min	Тур	Max	Unit	
CHARGES, CAPACITANCES &	GATE RESIS	TANCE	1					
Total Gate Charge	Q _{G(TOT)}		Q1		5.5			
			Q2		17		nC	
Gate-to-Drain Charge	Q_{GD}	Q1: V _{GS} = 4.5 V, V _{DS} = 13 V; I _D = 15 A	Q1		1.0			
		Q2: $V_{GS} = 4.5 \text{ V}, V_{DS} = 13 \text{ V}; I_D = 29 \text{ A}$	Q2		2.7		nC	
Gate-to-Source Charge	Q _{GS}	1	Q1		2.4			
			Q2		7.3		nC	
Total Gate Charge	Q _{G(TOT)}	Q1: V _{GS} = 10 V, V _{DS} = 13 V; I _D = 15 A	Q1		12		0	
		Q2: V _{GS} = 10 V, V _{DS} = 13 V; I _D = 29 A	Q2		37.5		nC	
SWITCHING CHARACTERISTI	CS, VGS = 4.5	V (Note 7)						
Turn-On Delay Time	t _{d(ON)}		Q1		9.5			
			Q2		19.1		ns	
Rise Time	t _r]	Q1		2.3			
		$V_{GS} = 4.5 \text{ V}$ Q1: $I_D = 15 \text{ A}$, $V_{DD} = 13 \text{ V}$, $R_G = 6 \Omega$	Q2		6.6		ns	
Turn-Off Delay Time	t _{d(OFF)}	Q2: $I_D = 29 \text{ A}$, $V_{DD} = 13 \text{ V}$, $R_G = 6 \Omega$	Q1		12.6			
			Q2		26.3		ns	
Fall Time	t _f		Q1		2.7			
			Q2		6.3		ns	
SWITCHING CHARACTERISTI	CS, VGS = 10	V (Note 7)						
Turn-On Delay Time	t _{d(ON)}		Q1		6.6		20	
			Q2		9.4		ns	
Rise Time	t _r		Q1		1.1		ns	
		$V_{GS} = 10 \text{ V}$ Q1: $I_D = 15 \text{ A}$, $V_{DD} = 13 \text{ V}$, $R_G = 6 \Omega$	Q2		2.3		110	
Turn-Off Delay Time	t _{d(OFF)}	Q2: $I_D = 29 \text{ A}$, $V_{DD} = 13 \text{ V}$, $R_G = 6 \Omega$	Q1		17.3		ne	
			Q2		37.6		ns	
Fall Time	t _f		Q1		1.7		ns	
			Q2		5.2		115	
DRAIN-SOURCE DIODE CHA	RACTERISTICS	S						
Forward Diode Voltage	V_{SD}	$V_{GS} = 0 V$, $T_J = 25^{\circ}C$	Q1		0.80	1.2		
		$I_S = 15 \text{ A}$ $T_J = 125^{\circ}\text{C}$			0.70		V	
		$V_{GS} = 0 V$, $T_J = 25^{\circ}C$	Q2		0.80	1.2	v	
		$I_{S} = 29 \text{ A}$ $T_{J} = 125^{\circ}\text{C}$			0.69			
Reverse Recovery Time	t _{RR}		Q1		19		ns	
		V _{GS} = 0 V Q1: I _S = 15 A, dI _S /dt = 100 A/μs	Q2		35		110	
Reverse Recovery Charge	Q _{RR}	Q1: I _S = 15 A, dI _S /dt = 100 A/μs Q2: I _S = 29 A, dI _S /dt = 100 A/μs			6.0		nC	
			Q2		21		110	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

6. Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$.

7. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS - Q1

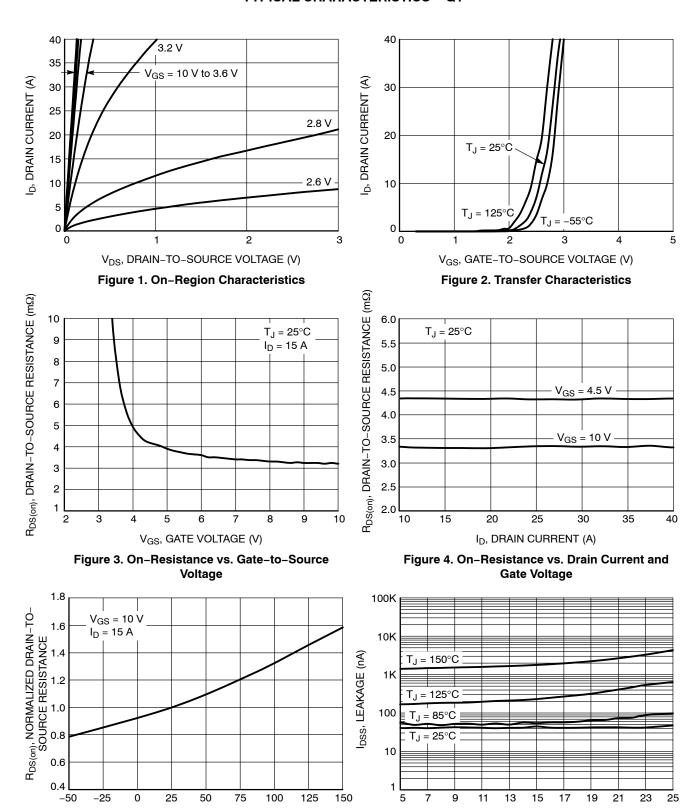


Figure 5. On–Resistance Variation with Temperature

T_J, JUNCTION TEMPERATURE (°C)

Figure 6. Drain-to-Source Leakage Current vs. Voltage

V_{DS}, DRAIN-TO-SOURCE VOLTAGE (V)

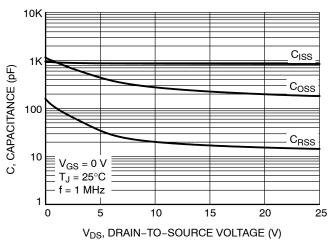


Figure 7. Capacitance Variation

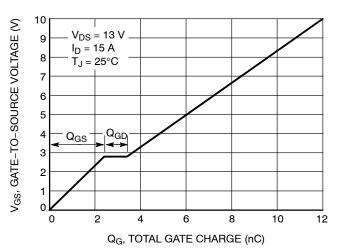


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

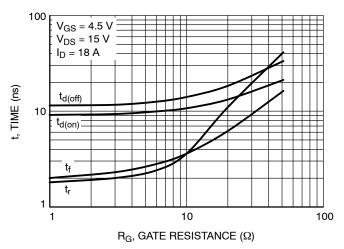


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

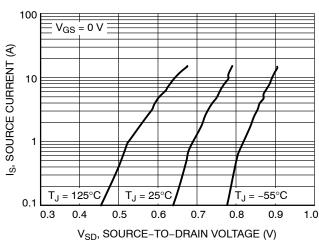


Figure 10. Diode Forward Voltage vs. Current

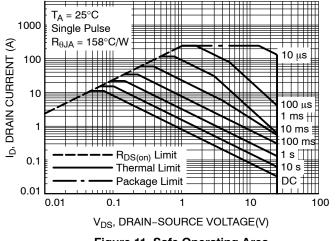


Figure 11. Safe Operating Area

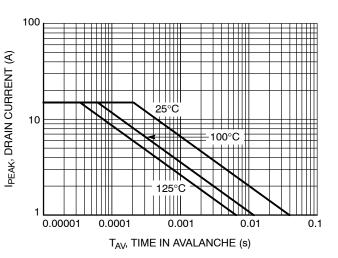


Figure 12. I_{PEAK} vs. Time in Avalanche

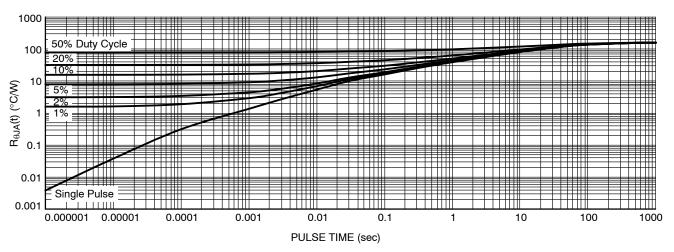


Figure 13. Thermal Characteristics

TYPICAL CHARACTERISTICS - Q2

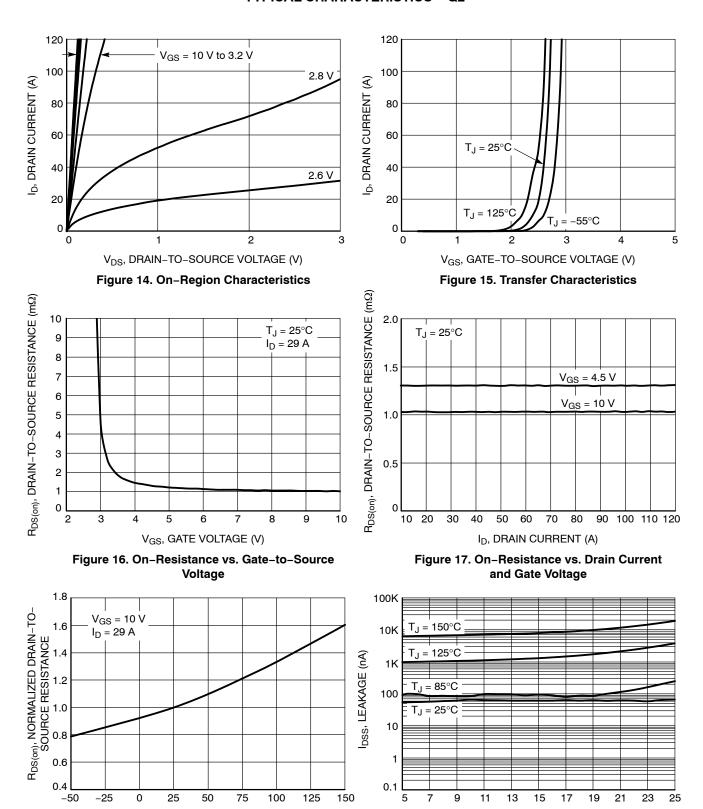
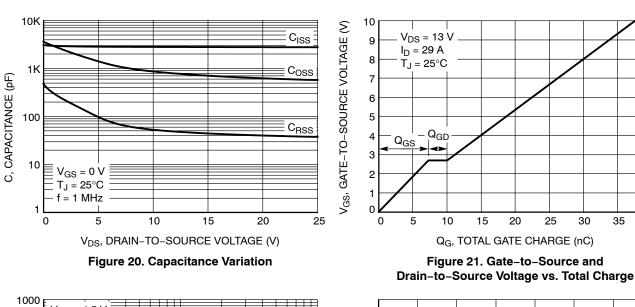


Figure 18. On-Resistance Variation with Temperature

T_J, JUNCTION TEMPERATURE (°C)

Figure 19. Drain-to-Source Leakage Current vs. Voltage

V_{DS}, DRAIN-TO-SOURCE VOLTAGE (V)



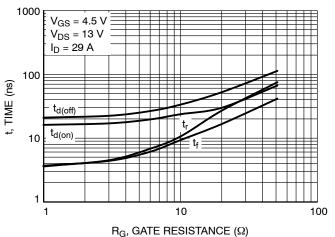
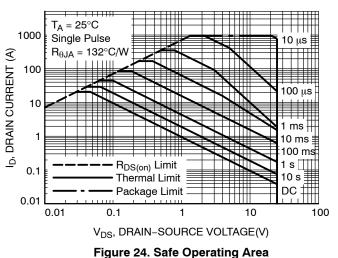
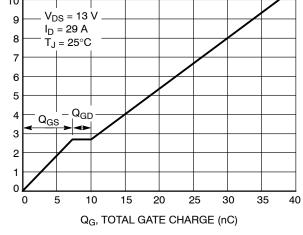


Figure 22. Resistive Switching Time Variation



vs. Gate Resistance



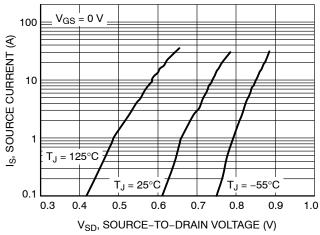


Figure 23. Diode Forward Voltage vs. Current

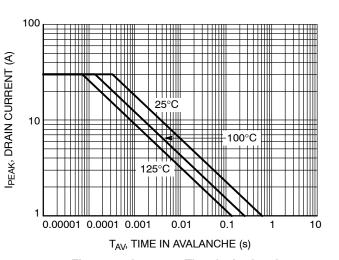


Figure 25. I_{PEAK} vs. Time in Avalanche

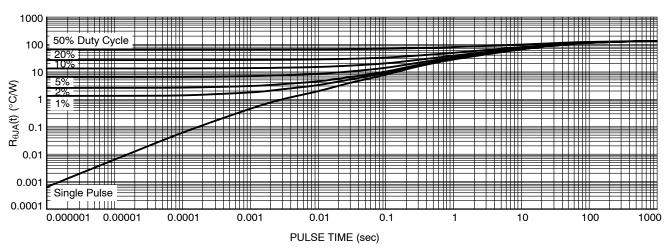


Figure 26. Thermal Characteristics





0.05 C

PIN #1

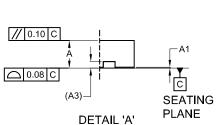
INDICATOR

PQFN8 3.3X3.3, 0.65P CASE 483AZ ISSUE B

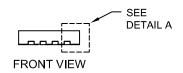
DATE 14 FEB 2022

NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
- DIMENSIONS DO NOT INCLUDE BURSS OR MOLD FLASH. MOLD FLASH OR BURRS DOES NOT EXCEED 0.10MM.
- 5. SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.
- 6. IT IS RECOMMENDED TO HAVE NO TRACES OR VIAS WITHIN THE KEEP OUT AREA.

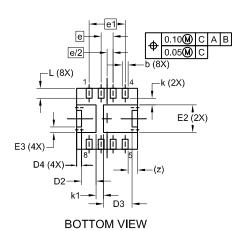


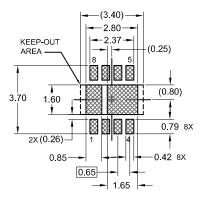
SCALE 2:1



TOP VIEW

0.05 C





LAND PATTERN
RECOMMENDATION

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PB-FREE STRATEGY AND SOLDERING
DETAILS, PLEASE DOWNLOAD THE ON
SEMICONDUCTOR SOLDERING AND
MOUNTING TECHNIQUES REFERENCE
MANUAL, SOLDERRM/D.

DIM	MIL	MILLIMETERS					
<i>5</i> ,	MIN	NOM	MAX				
Α	0.70	0.75	0.80				
A1	0.00	1	0.05				
A3		0.20 REF					
b	0.27	0.32	0.37				
D	3.20	3.30	3.40				
D2	0.69	0.79	0.89				
D3	1.45	1.55	1.65				
D4	0.16	0,26	0.36				
Е	3.20	3.30	3.40				
E2	1.40	1.60					
E3	-	0.30 REF					
е	U	0.65 BSC					
e1		1.95 BSC					
e/2	0.325 BSC						
k	0.36 REF						
k1		0.40 REF					
L	0.44	0.54	0.64				
z	0.52 REF						

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DESCRIPTION:	PQFN8 3.3X3.3, 0.65P		PAGE 1 OF 1		

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